


<b>Search Notes</b>  	<b>Application/Control No.</b>  10756781	<b>Applicant(s)/Patent Under Reexamination</b>  ZHANG, YUN
	<b>Examiner</b>  Shikhman, Max	<b>Art Unit</b>  2112

SEARCHED			
Class	Subclass	Date	Examiner
382	167	1/16/2007	Max Shikhman
382	274	1/15/2007	Max Shikhman

SEARCH NOTES		
Search Notes	Date	Examiner
US PAT, US PGPUB, DERWENT, JPO, EPO	1/16/2007	Max Shikhman
IEEE, GOOGLE, Yahoo, Citeseer	1/16/2007	Max Shikhman

INTERFERENCE SEARCH			
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